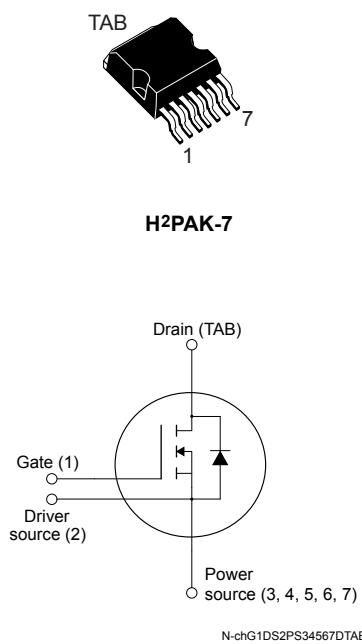


Automotive-grade N-channel 650 V, 38 mΩ typ., 51 A MDmesh DM9 Power MOSFET in an H²PAK-7 package



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D
STH65N050DM9-7AG	650 V	50 mΩ	51 A

- AEC-Q101 qualified 
- Fast-recovery body diode
- Very low FOM ($R_{DS(on)} \cdot Q_g$)
- Low gate charge, input capacitance and resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Excellent switching performance thanks to the extra driving source pin

Applications

- DC/DC converter for EV/HEV
- On board charger (OBC)

Description

This N-channel Power MOSFET is based on the most innovative super-junction MDmesh DM9 technology, suitable for medium/high voltage MOSFETs featuring very low R_{DS(on)} per area coupled with a fast-recovery diode. The silicon-based DM9 technology benefits from a multi-drain manufacturing process which allows an enhanced device structure. The fast-recovery diode featuring very low recovery charge (Q_{rr}), time (t_{rr}) and R_{DS(on)} makes this fast-switching super-junction Power MOSFET tailored for the most demanding high-efficiency bridge topologies and ZVS phase-shift converters.

Product status link

[STH65N050DM9-7AG](#)

Product summary

Order code	STH65N050DM9-7AG
Marking	65A050DM9
Package	H ² PAK-7
Packing	Tape and reel

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	± 30	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	51	A
	Drain current (continuous) at $T_C = 100^\circ\text{C}$	32	
$I_{DM}^{(2)}$	Drain current (pulsed)	220	A
P_{TOT}	Total power dissipation at $T_C = 25^\circ\text{C}$	266	W
$dv/dt^{(3)}$	Peak diode recovery voltage slope	120	V/ns
$di/dt^{(3)}$	Peak diode recovery current slope	1000	A/ μs
$dv/dt^{(4)}$	MOSFET dv/dt ruggedness	120	V/ns
T_{stg}	Storage temperature range	-55 to 150	$^\circ\text{C}$
T_J	Operating junction temperature range		$^\circ\text{C}$

1. Referred to TO-247 long leads package.
2. Pulse width limited by safe operating area.
3. $I_{SD} \leq 25.5 \text{ A}$, $V_{DS} (\text{peak}) < V_{(BR)DSS}$, $V_{DD} = 400 \text{ V}$.
4. $V_{DS} (\text{peak}) < V_{(BR) DSS}$, $V_{DD} = 400 \text{ V}$.

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance, junction-to-case	0.47	$^\circ\text{C}/\text{W}$
$R_{thJA}^{(1)}$	Thermal resistance, junction-to-ambient	30	$^\circ\text{C}/\text{W}$

1. When mounted on 1 inch² FR-4, 2 Oz copper board.

Table 3. Avalanche characteristics

Symbol	Parameter	Value	Unit
I_{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_J max.)	6	A
E_{AS}	Single pulse avalanche energy (starting $T_J = 25^\circ\text{C}$, $I_D = I_{AR}$, $V_{DD} = 50 \text{ V}$)	760	mJ

2 Electrical characteristics

$T_C = 25^\circ\text{C}$ unless otherwise specified.

Table 4. On/off-states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			V
I_{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$			5	μA
I_{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	3.5	4.0	4.5	V
$R_{\text{DS(on)}}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 25.5 \text{ A}$		38	50	$\text{m}\Omega$

Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance	$V_{DS} = 400 \text{ V}, f = 250 \text{ kHz}, V_{GS} = 0 \text{ V}$	-	4680	-	pF
C_{oss}	Output capacitance		-	76	-	pF
$C_{\text{oss eq.}}^{(1)}$	Equivalent output capacitance	$V_{DS} = 0 \text{ to } 400 \text{ V}, V_{GS} = 0 \text{ V}$	-	1070	-	pF
R_g	Intrinsic gate resistance	$f = 250 \text{ kHz, open drain}$	-	1	-	Ω
Q_g	Total gate charge	$V_{DD} = 400 \text{ V}, I_D = 25.5 \text{ A}, V_{GS} = 0 \text{ to } 10 \text{ V}$ (see Figure 14. Test circuit for gate charge behavior)	-	100	-	nC
Q_{gs}	Gate-source charge		-	26	-	nC
Q_{gd}	Gate-drain charge		-	36	-	nC

1. $C_{\text{oss eq.}}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to stated value.

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(\text{on})}$	Turn-on delay time	$V_{DD} = 400 \text{ V}, I_D = 25.5 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 13. Switching times test circuit for resistive load and Figure 18. Switching time waveform)	-	29	-	ns
t_r	Rise time		-	7	-	ns
$t_{d(\text{off})}$	Turn-off delay time		-	80	-	ns
t_f	Fall time		-	5	-	ns

Table 7. Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}^{(1)}$	Source-drain current		-		51	A
$I_{SDM}^{(2)}$	Source-drain current (pulsed)		-		220	A
$V_{SD}^{(3)}$	Forward on voltage	$V_{GS} = 0 \text{ V}$, $I_{SD} = 51 \text{ A}$	-	1.1	1.6	V
t_{rr}	Reverse recovery time	$I_{SD} = 51 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$,	-	170		ns
Q_{rr}	Reverse recovery charge	$V_{DD} = 150 \text{ V}$	-	1.2		μC
I_{RRM}	Reverse recovery current	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	12		A
t_{rr}	Reverse recovery time	$I_{SD} = 51 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$,	-	225		ns
Q_{rr}	Reverse recovery charge	$V_{DD} = 150 \text{ V}$, $T_J = 150 \text{ }^\circ\text{C}$	-	2.2		μC
I_{RRM}	Reverse recovery current	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	18		A

1. Referred to TO-247 long leads package.
2. Pulse width is limited by safe operating area.
3. Pulsed: pulse duration = 300 μs , duty cycle 1.5%.

2.1 Electrical characteristics (curves)

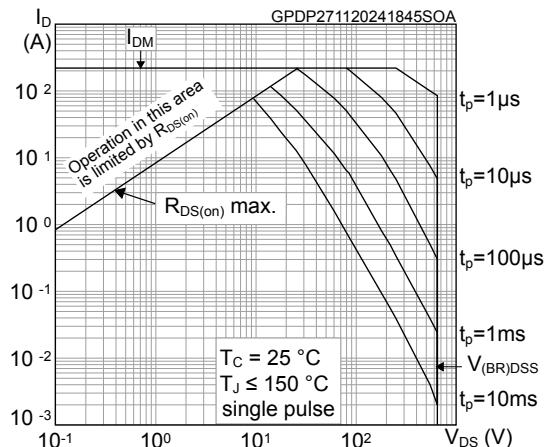
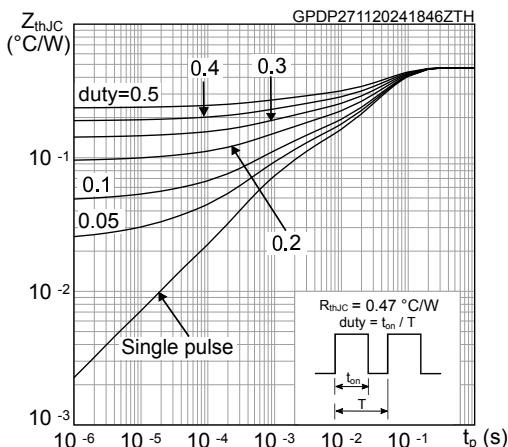
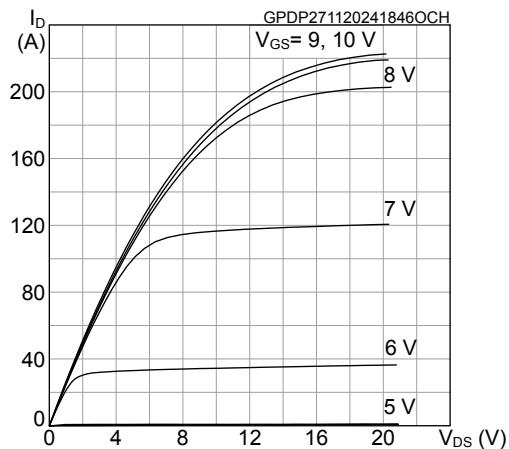
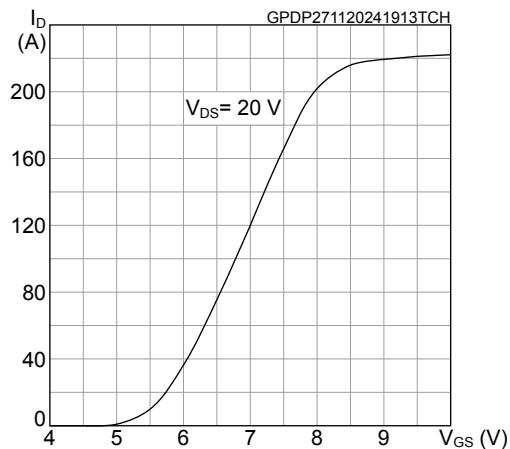
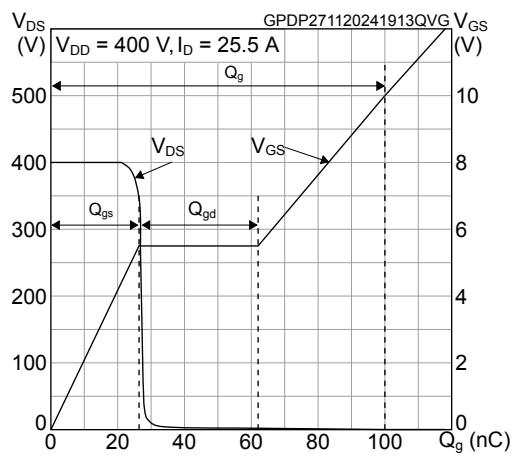
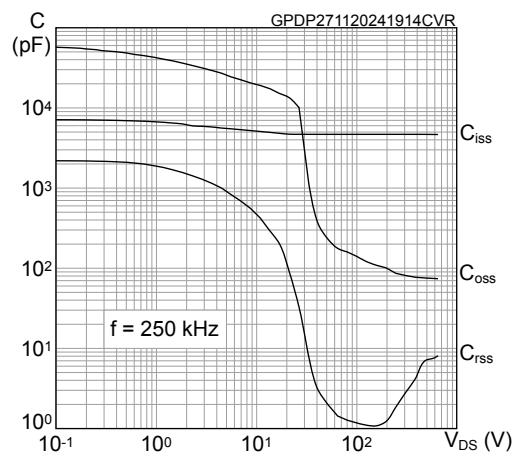
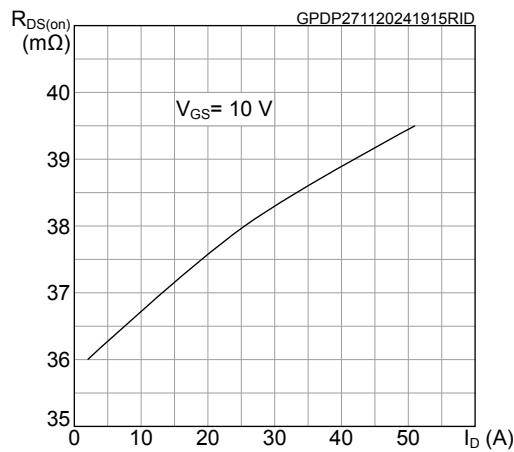
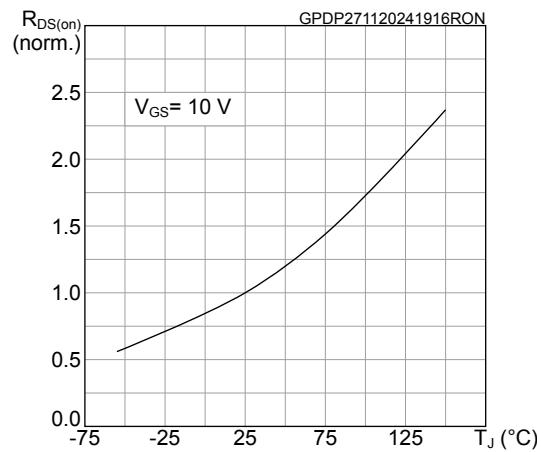
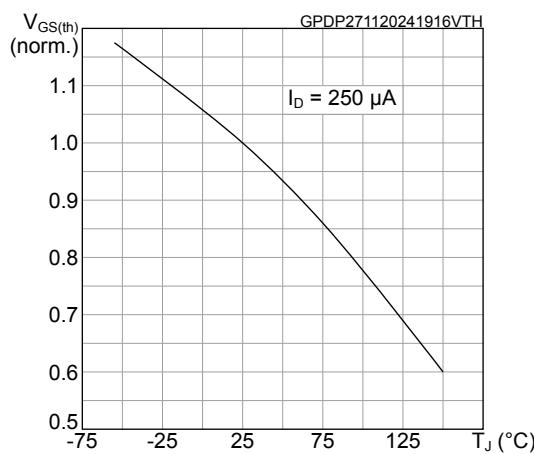
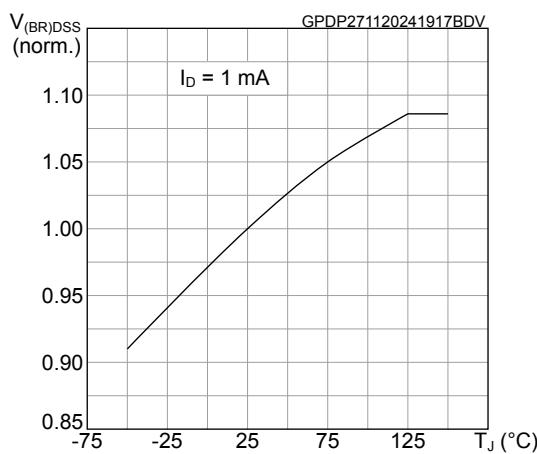
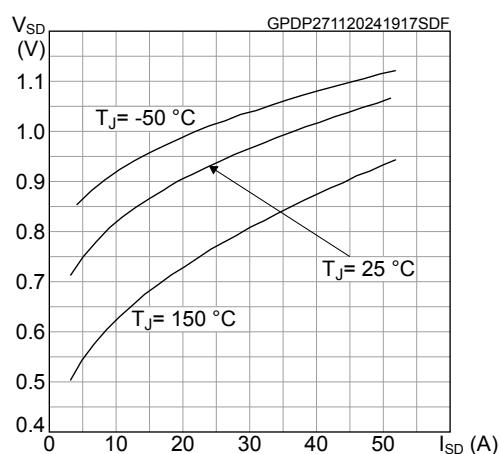
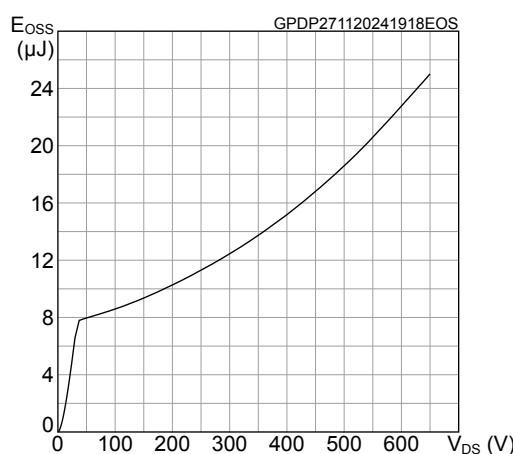
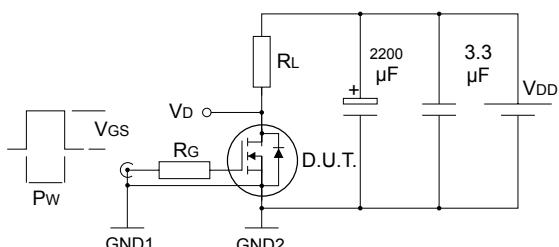
Figure 1. Safe operating area

Figure 2. Maximum transient thermal impedance

Figure 3. Typical output characteristics

Figure 4. Typical transfer characteristics

Figure 5. Typical gate charge characteristics

Figure 6. Typical capacitance characteristics


Figure 7. Typical drain-source on-resistance

Figure 8. Normalized on-resistance vs temperature

Figure 9. Normalized gate threshold vs temperature

Figure 10. Normalized breakdown voltage vs temperature

Figure 11. Typical reverse diode forward characteristics

Figure 12. Typical output capacitance stored energy


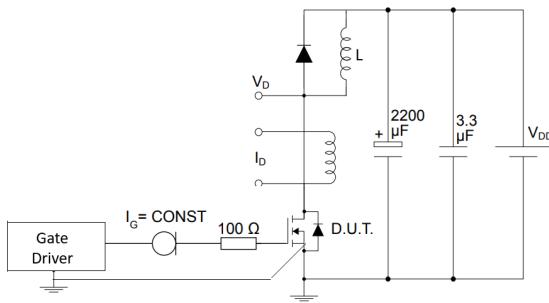
3 Test circuits

Figure 13. Switching times test circuit for resistive load



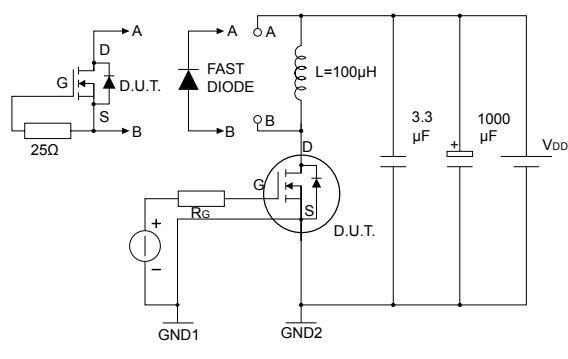
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Figure 14. Test circuit for gate charge behavior



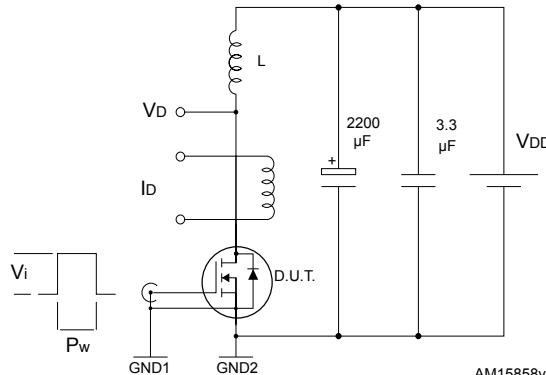
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Figure 15. Test circuit for inductive load switching and diode recovery times



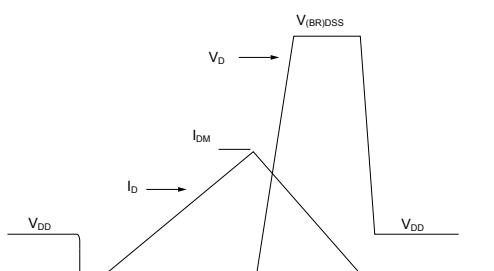
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Figure 16. Unclamped inductive load test circuit



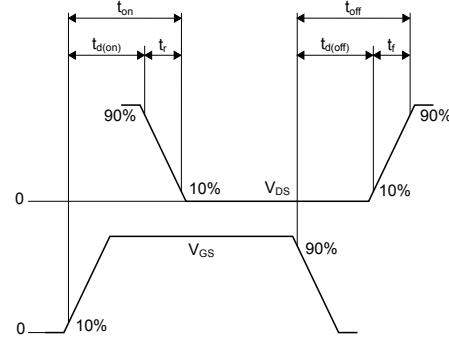
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Figure 17. Unclamped inductive waveform



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Figure 18. Switching time waveform



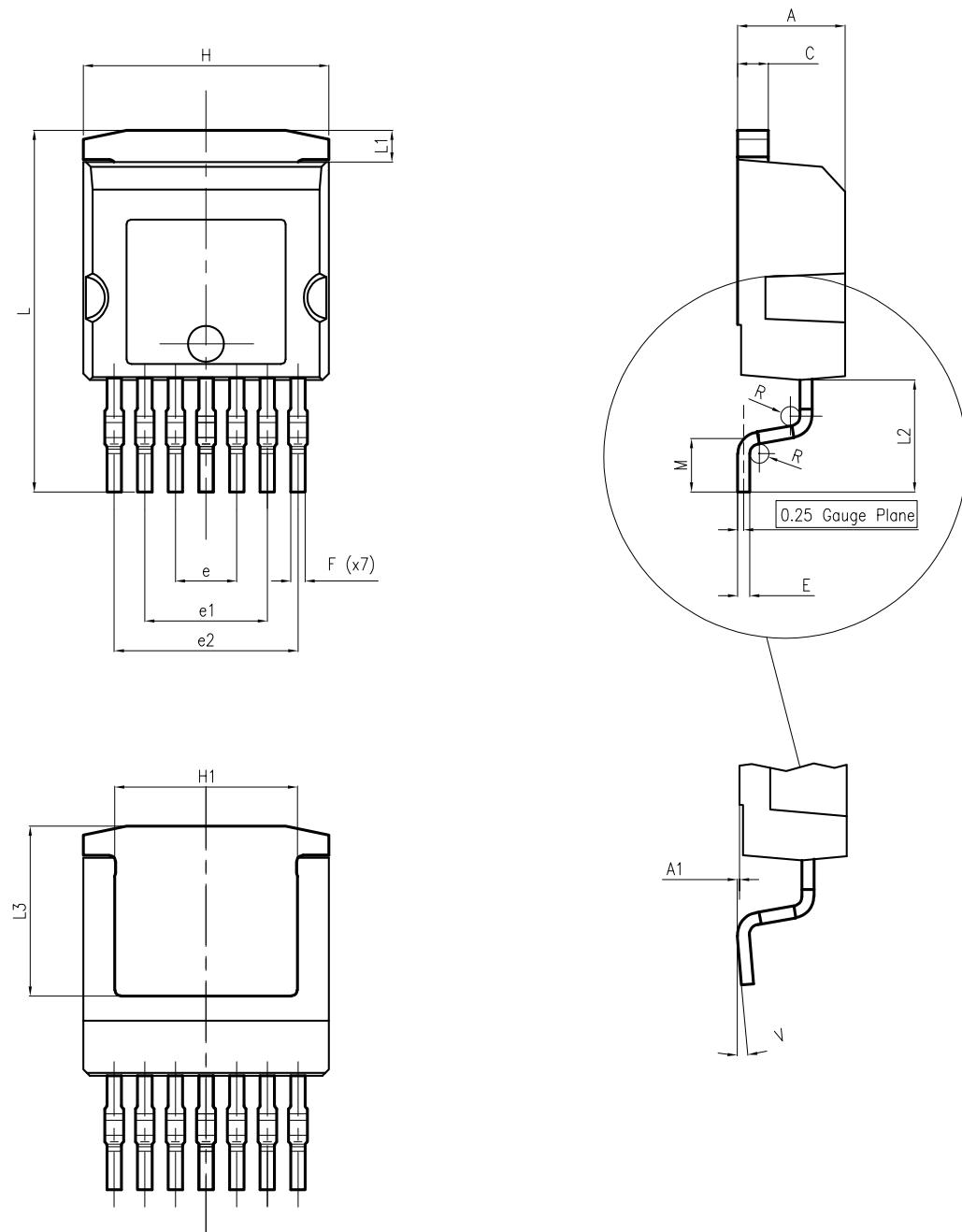
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4 Package information

To meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 H²PAK-7 package information

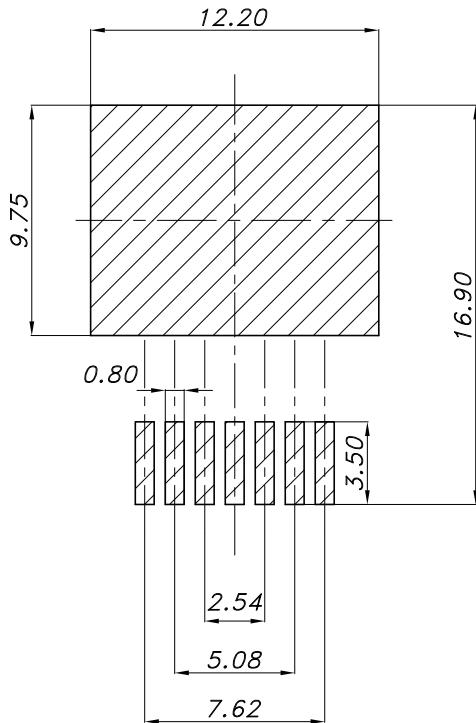
Figure 19. H²PAK-7 package outline



DM00249216_6

Table 8. H²PAK-7 package mechanical data

Dim.	mm	
	Min.	Max.
A	4.30	4.80
A1	0.03	0.20
C	1.17	1.37
e	2.34	2.74
e1	4.88	5.28
e2	7.42	7.82
E	0.45	0.60
F	0.50	0.70
H	10.00	10.40
H1	7.40	8.00
L	14.75	15.25
L1	1.27	1.40
L2	4.35	4.95
L3	6.85	7.25
M	1.90	2.50
R	0.20	0.60
V	0°	8°

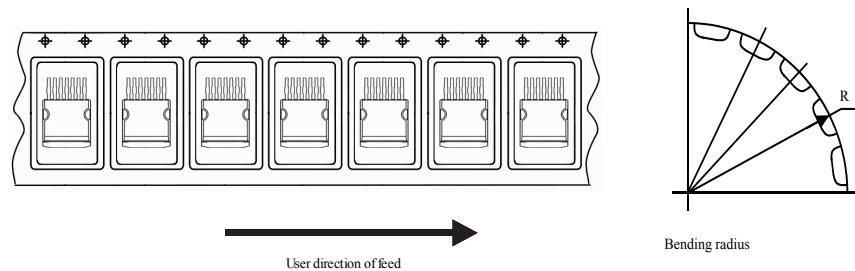
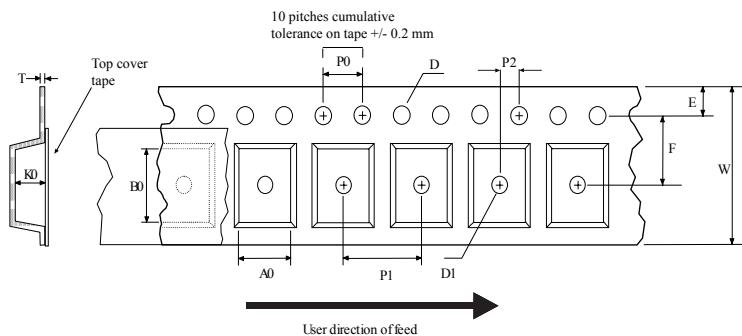
Figure 20. H²PAK-7 recommended footprint

footprint_DM00249216_6

Note: Dimensions are in mm.

4.2 Packing information

Figure 21. Tape outline



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Figure 22. Reel outline

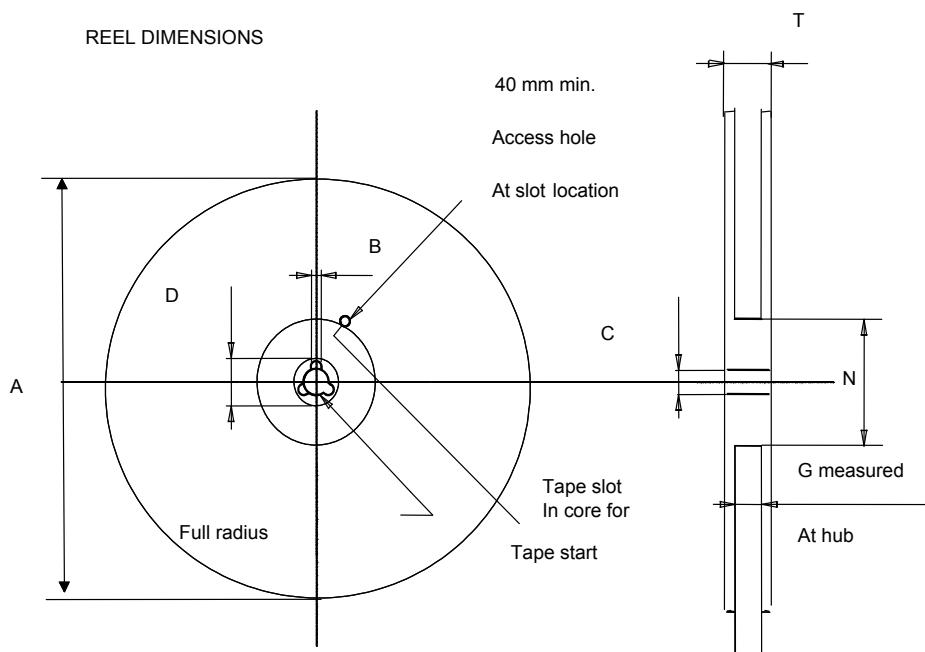


Table 9. Tape and reel mechanical data

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	10.5	10.7	A		330
B0	15.7	15.9	B	1.5	
D	1.5	1.6	C	12.8	13.2
D1	1.59	1.61	D	20.2	
E	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
K0	4.8	5.0	T		30.4
P0	3.9	4.1			
P1	11.9	12.1		Base quantity	1000
P2	1.9	2.1		Bulk quantity	1000
R	50				
T	0.25	0.35			
W	23.7	24.3			

Revision history

Table 10. Document revision history

Date	Revision	Changes
05-Jun-2024	1	First release.
01-Oct-2024	2	Modified $R_{DS(on)}$ value in <i>Table 3. On/off-states</i> .
28-Nov-2024	3	Updated <i>Features</i> on cover page. Added <i>Table 3. Avalanche characteristics</i> . Updated <i>Table 5. Dynamic characteristics</i> , <i>Table 6. Switching times</i> and <i>Table 7. Source-drain diode</i> . Updated <i>Section 2.1: Electrical characteristics (curves)</i> . Updated <i>Section 3: Test circuits</i> . Minor text changes.
28-Jan-2025	4	Updated <i>Applications</i> . Updated <i>Figure 10. Normalized breakdown voltage vs temperature</i> .

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